## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | VAN BEEK ET AL. | Examiner | Art Unit | IYABO S. ALLI | 2877 | Page 1 of 1

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\*A copy of this reference is not being furnished with this Of fice action. (See MPEP § 707.05(a).)

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